

PSMN035-150B

N-channel TrenchMOS SiliconMAX standard level FET

Rev. 04 — 17 November 2009

Product data sheet

1. Product profile

1.1 General description

SiliconMAX standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Suitable for high frequency applications due to fast switching characteristics

1.3 Applications

- Switched-mode power supplies

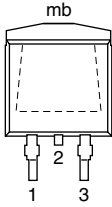
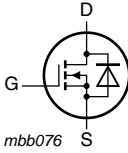
1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25\text{ °C}$; $T_j \leq 175\text{ °C}$	-	-	150	V
I_D	drain current	$T_{mb} = 25\text{ °C}$; see Figure 1 and 2	-	-	50	A
P_{tot}	total power dissipation	$T_{mb} = 25\text{ °C}$; see Figure 3	-	-	250	W
Dynamic characteristics						
Q_{GD}	gate-drain charge	$V_{GS} = 10\text{ V}$; $I_D = 50\text{ A}$; $V_{DS} = 120\text{ V}$; $T_j = 25\text{ °C}$; see Figure 13	-	33	45	nC
Static characteristics						
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10\text{ V}$; $I_D = 25\text{ A}$; $T_j = 25\text{ °C}$; see Figure 11 and 12	-	30	35	m Ω

2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain [1]		
3	S	source		
mb	D	mounting base; connected to drain		

SOT404 (D2PAK)

[1] It is not possible to make connection to pin 2.

3. Ordering information

Table 3. Ordering information

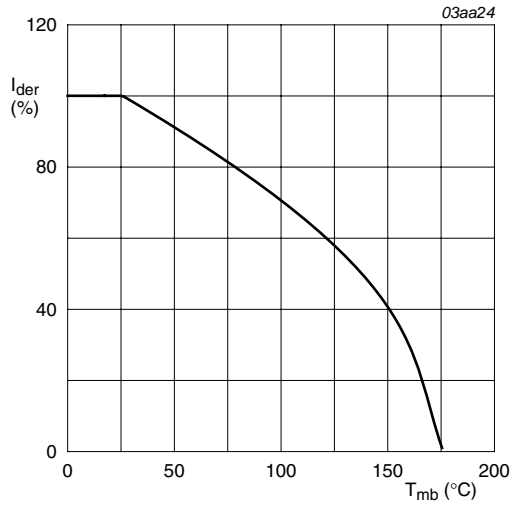
Type number	Package		Version
	Name	Description	
PSMN035-150B	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

4. Limiting values

Table 4. Limiting values

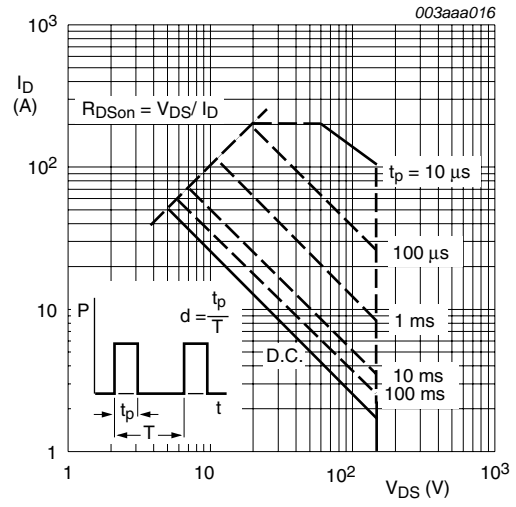
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25\text{ °C}$; $T_j \leq 175\text{ °C}$	-	150	V
V_{DGR}	drain-gate voltage	$T_j \leq 175\text{ °C}$; $T_j \geq 25\text{ °C}$; $R_{GS} = 20\text{ k}\Omega$	-	150	V
V_{GS}	gate-source voltage		-20	20	V
I_D	drain current	$T_{mb} = 100\text{ °C}$; see Figure 1 and 2	-	36	A
		$T_{mb} = 25\text{ °C}$; see Figure 1 and 2	-	50	A
I_{DM}	peak drain current	$t_p \leq 10\text{ }\mu\text{s}$; pulsed; $T_{mb} = 25\text{ °C}$; see Figure 2	-	200	A
P_{tot}	total power dissipation	$T_{mb} = 25\text{ °C}$; see Figure 3	-	250	W
T_{stg}	storage temperature		-55	175	°C
T_j	junction temperature		-55	175	°C
Source-drain diode					
I_S	source current	$T_{mb} = 25\text{ °C}$	-	50	A
I_{SM}	peak source current	$t_p \leq 10\text{ }\mu\text{s}$; pulsed; $T_{mb} = 25\text{ °C}$	-	200	A
Avalanche ruggedness					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	$V_{GS} = 10\text{ V}$; $T_{j(\text{init})} = 25\text{ °C}$; $I_D = 47\text{ A}$; $V_{sup} \leq 50\text{ V}$; unclamped; $t_p = 0.1\text{ ms}$; $R_{GS} = 50\text{ }\Omega$; see Figure 4	-	460	mJ
I_{AS}	non-repetitive avalanche current	$V_{sup} \leq 50\text{ V}$; $V_{GS} = 10\text{ V}$; $T_{j(\text{init})} = 25\text{ °C}$; $R_{GS} = 50\text{ }\Omega$; unclamped; see Figure 4	-	50	A



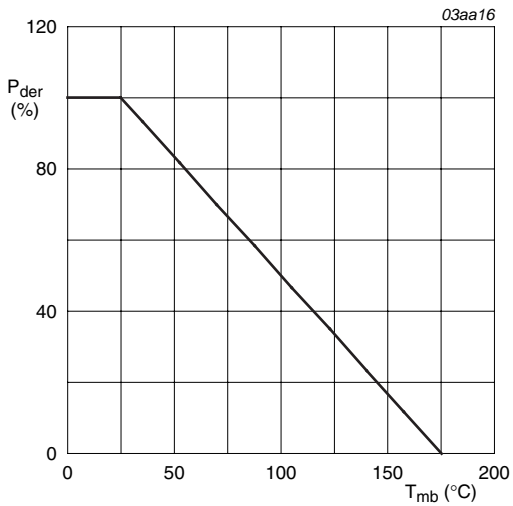
$$I_{der} = \frac{I_D}{I_{D(25^\circ C)}} \times 100\%$$

Fig 1. Normalized continuous drain current as a function of mounting base temperature



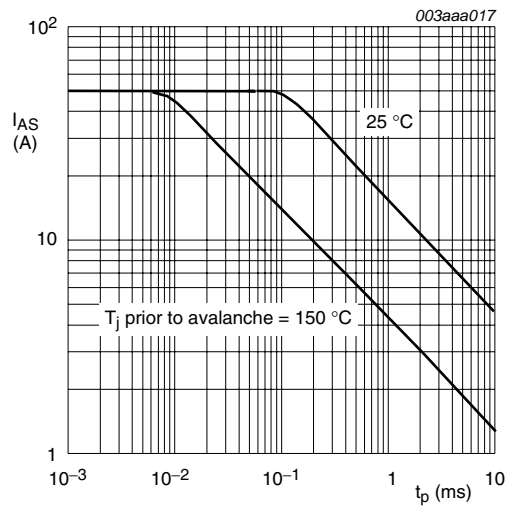
$T_{mb} = 25^\circ C; I_{DM}$ is single pulse

Fig 2. Safe operating area; continuous and peak drain currents as a function of drain-source volt



$$P_{der} = \frac{P_{tot}}{P_{tot(25^\circ C)}} \times 100\%$$

Fig 3. Normalized total power dissipation as a function of mounting base temperature



Unclamped inductive load; $V_{DS} \leq 15V; R_{GS} = 50\Omega; V_{GS} = 10V$

Fig 4. Non-repetitive avalanche ruggedness current as a function of pulse duration

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 5	-	0.6	-	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	mounted on printed-circuit board; minimum footprint	-	-	50	K/W

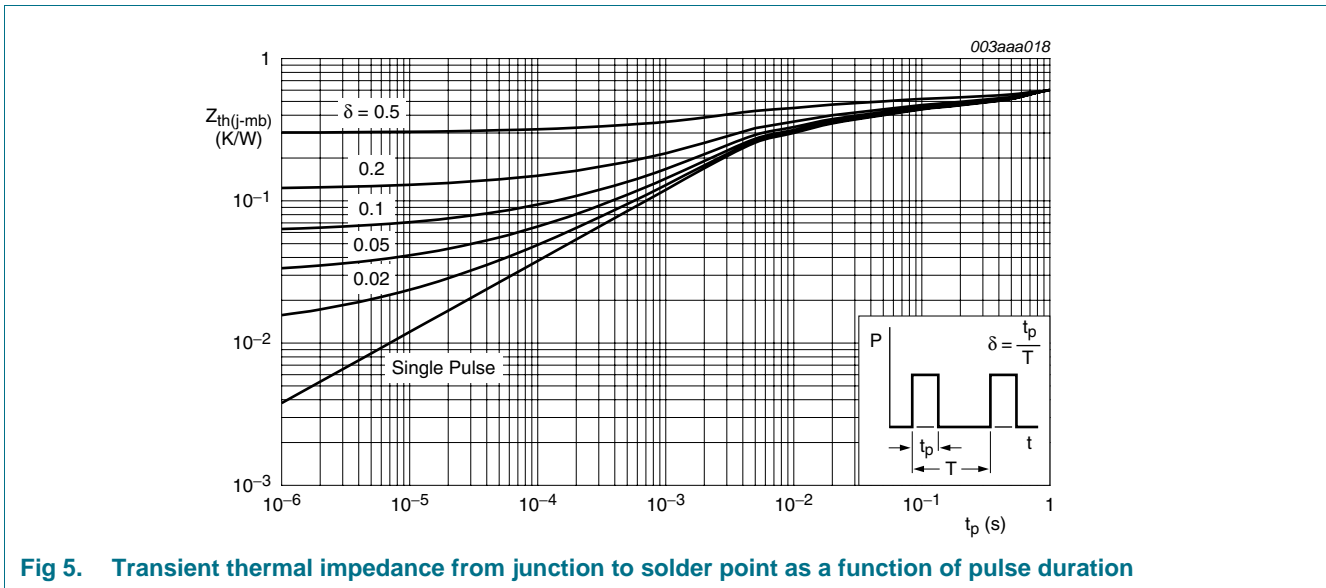


Fig 5. Transient thermal impedance from junction to solder point as a function of pulse duration

6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A$; $V_{GS} = 0 V$; $T_j = 25 \text{ }^\circ C$	150	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 175 \text{ }^\circ C$; see Figure 10	1	-	-	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 25 \text{ }^\circ C$; see Figure 10	2	3	4	V
I_{DSS}	drain leakage current	$V_{DS} = 150 V$; $V_{GS} = 0 V$; $T_j = 25 \text{ }^\circ C$	-	0.05	10	μA
		$V_{DS} = 150 V$; $V_{GS} = 0 V$; $T_j = 175 \text{ }^\circ C$	-	-	500	μA
I_{GSS}	gate leakage current	$V_{GS} = 10 V$; $V_{DS} = 0 V$; $T_j = 25 \text{ }^\circ C$	-	2	100	nA
		$V_{GS} = -10 V$; $V_{DS} = 0 V$; $T_j = 25 \text{ }^\circ C$	-	2	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10 V$; $I_D = 25 A$; $T_j = 175 \text{ }^\circ C$; see Figure 11 and 12	-	-	98	m Ω
		$V_{GS} = 10 V$; $I_D = 25 A$; $T_j = 25 \text{ }^\circ C$; see Figure 11 and 12	-	30	35	m Ω
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	$I_D = 50 A$; $V_{DS} = 120 V$; $V_{GS} = 10 V$; $T_j = 25 \text{ }^\circ C$; see Figure 13	-	79	-	nC
Q_{GS}	gate-source charge		-	17	-	nC
Q_{GD}	gate-drain charge		-	33	45	nC
C_{iss}	input capacitance	$V_{DS} = 25 V$; $V_{GS} = 0 V$; $f = 1 \text{ MHz}$; $T_j = 25 \text{ }^\circ C$; see Figure 14	-	4720	-	pF
C_{oss}	output capacitance	$V_{DS} = 25 V$; $V_{GS} = 0 V$; $f = 1 \text{ MHz}$; $T_j = 25 \text{ }^\circ C$; see Figure 13	-	456	-	pF
C_{rss}	reverse transfer capacitance		-	208	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = 75 V$; $R_L = 1.5 \Omega$; $V_{GS} = 10 V$; $R_{G(ext)} = 5.6 \Omega$; $T_j = 25 \text{ }^\circ C$	-	25	-	ns
t_r	rise time		-	138	-	ns
$t_{d(off)}$	turn-off delay time		-	79	-	ns
t_f	fall time		-	93	-	ns
Source-drain diode						
V_{SD}	source-drain voltage	$I_S = 25 A$; $V_{GS} = 0 V$; $T_j = 25 \text{ }^\circ C$; see Figure 15	-	0.85	1.2	V
t_{rr}	reverse recovery time	$I_S = 20 A$; $di_S/dt = -100 A/\mu s$; $V_{GS} = 0 V$; $V_{DS} = 30 V$; $T_j = 25 \text{ }^\circ C$	-	118	-	ns
Q_r	recovered charge		-	0.66	-	nC

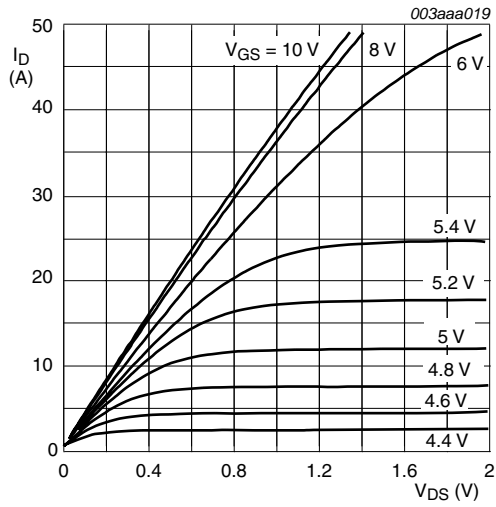


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values

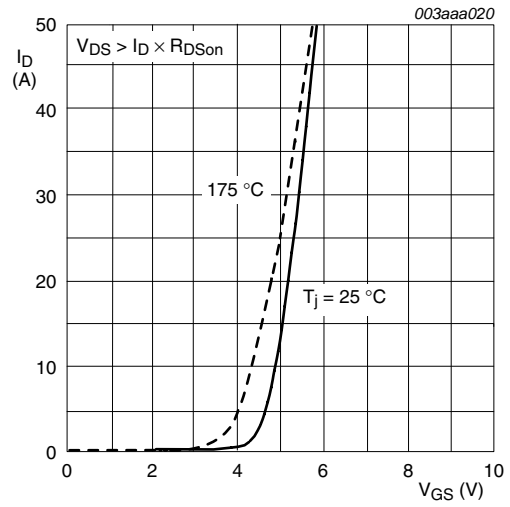


Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values

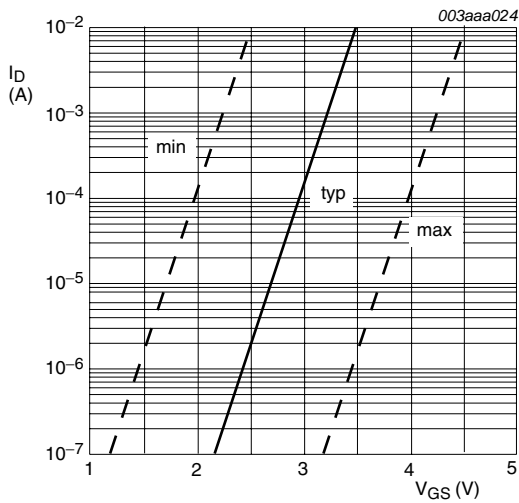


Fig 8. Sub-threshold drain current as a function of gate-source voltage

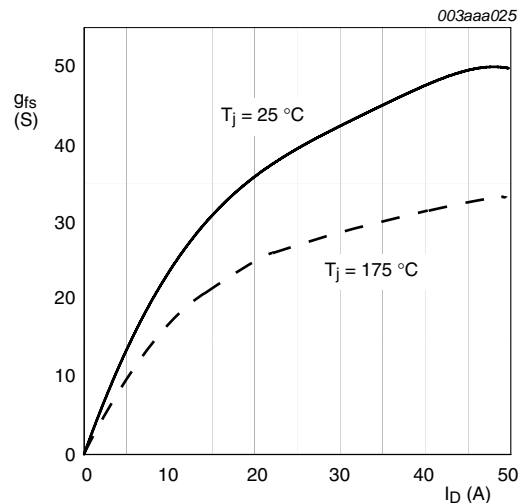
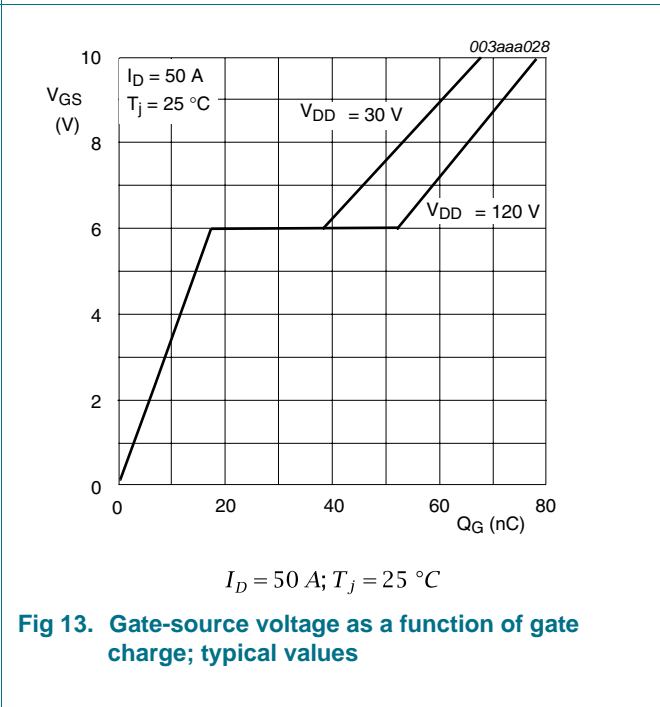
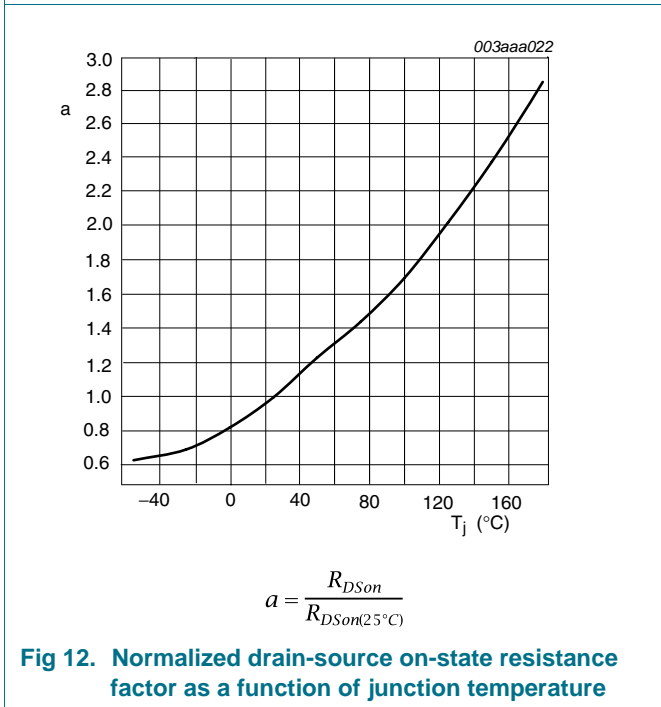
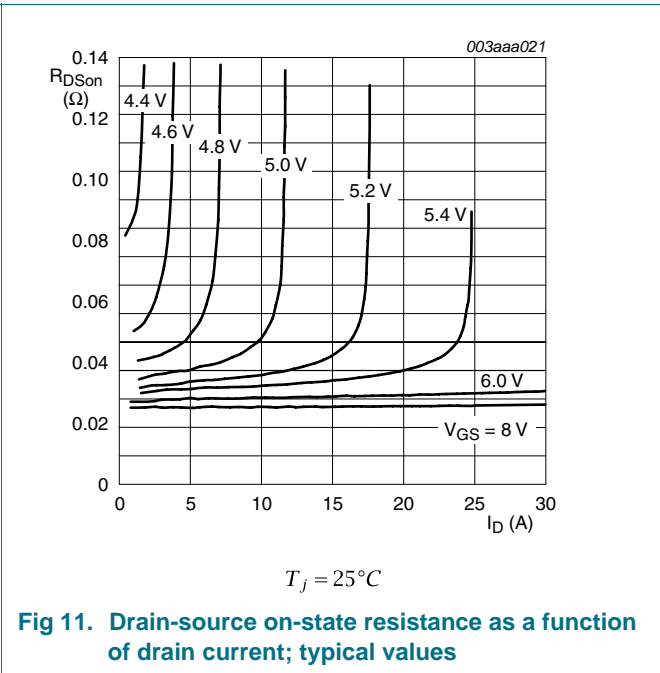
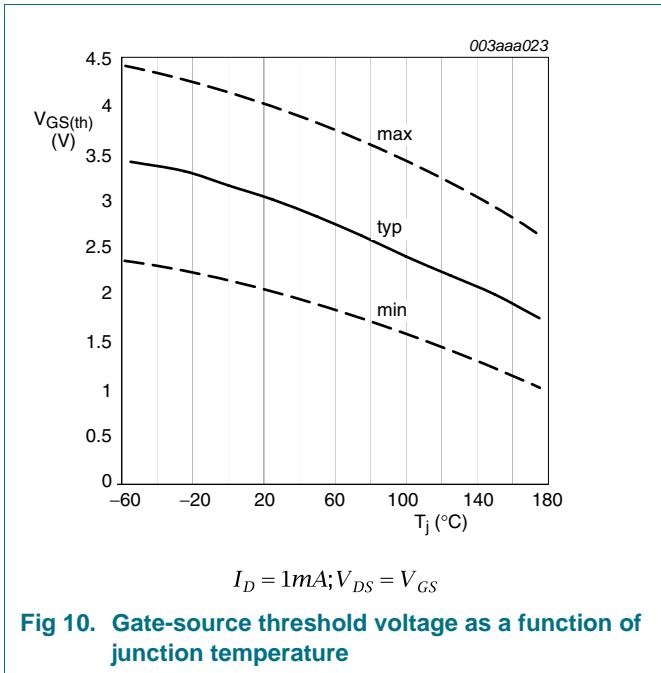
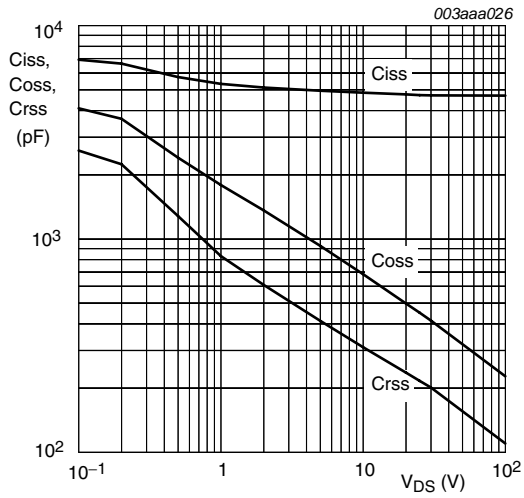


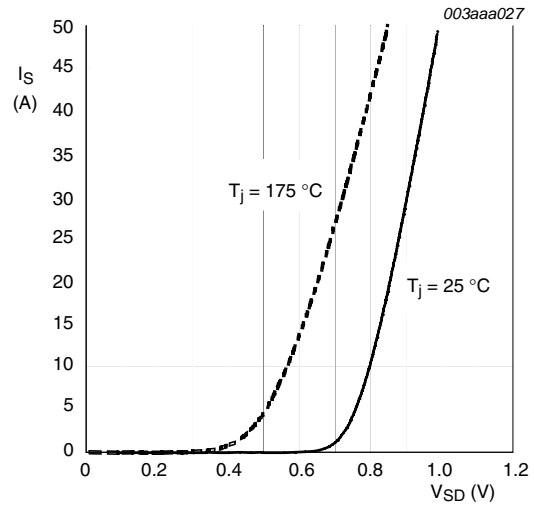
Fig 9. Forward transconductance as a function of drain current; typical values





$V_{GS} = 0V; f = 1MHz$

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



$T_j = 25^\circ C \text{ and } 175^\circ C; V_{GS} = 0V$

Fig 15. Source current as a function of source-drain voltage; typical values

7. Package outline

Plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)

SOT404

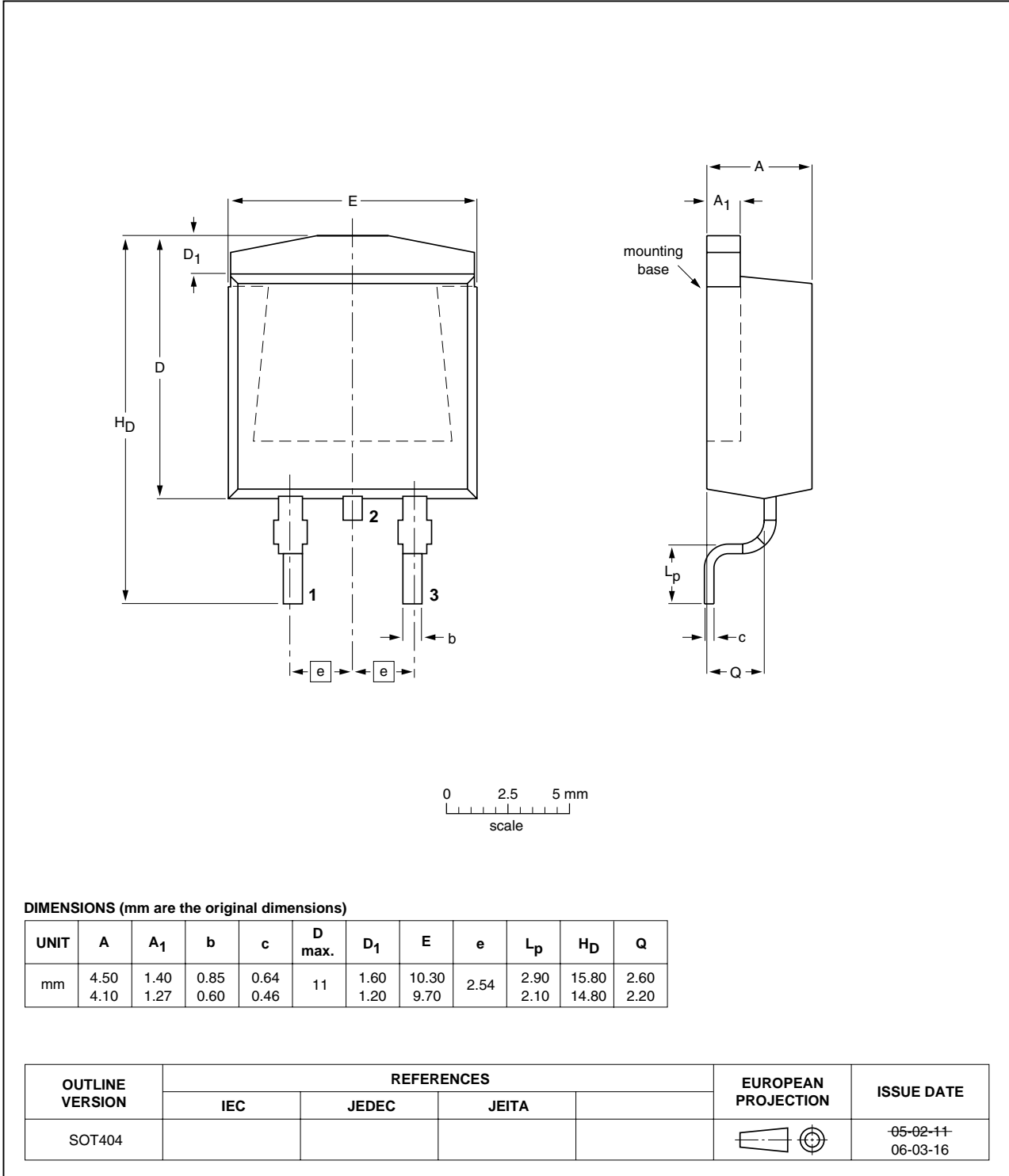


Fig 16. Package outline SOT404 (D2PAK)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN035-150B_4	20091117	Product data sheet	-	PSMN035-150_SERIES_HG_3
Modifications:		<ul style="list-style-type: none"> The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. Legal texts have been adapted to the new company name where appropriate. Type number PSMN035-150B separated from data sheet PSMN035-150_SERIES_HG_3. 		
PSMN035-150_SERIES_HG_3	20000328	Product specification	-	PSMN035-150_SERIES_2
PSMN035-150_SERIES_2	19990801	Product specification	-	PSMN035-150_SERIES_1
PSMN035-150_SERIES_1	19990201	Objective specification	-	-

9. Legal information

9.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at <http://www.nxp.com>.

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